



Who Uses CST Studio Suite for Particle Dynamics Simulation?

Anyone who has to deal with electromagnetic problems that involve the effect of charged particle dynamics will greatly benefit from using CST Studio Suite. The program is especially suited to the fast, efficient analysis and design of components like electron guns, deflecting devices, guiding configurations and more. Since the underlying method is a general 3D approach, CST Studio Suite for Particle Dynamics Simulation can solve virtually any field problem that involves interaction with charged particles.

Key Features for Particle Dynamics Simulation

The following list gives you an overview of the main features for this part of CST Studio Suite. Please note that not all of these features may be available to you because of license restrictions. Please contact a sales office for more information.

General

- Native graphical user interface based on Windows 7 (SP1 or later), Windows 2008 Server R2 (SP1 or later), Windows 8.1, Windows 2012 Server R2, Windows 10, Windows Server 2016 and Windows Server 2019
- The structure can be viewed either as a 3D model or as a schematic. The latter allows a parametrized approach of coupled simulation with our System Assembly and Modeling workflow.
- Various independent solver strategies allow accurate results with a high performance
- For specific solvers, highly advanced numerical techniques offer features like Perfect Boundary Approximation (PBA)® for hexahedral grids and curved and higher order elements for tetrahedral meshes

Structure Modeling

- Advanced ACIS-based, parametric solid modeling front end with excellent structure visualization
- Feature-based hybrid modeler allows quick structural changes
- Import of 3D CAD data from ACIS SAT (e.g. AutoCAD®), ACIS SAB, Autodesk Inventor®, IGES, VDA-FS, STEP, Pro/ENGINEER®, CATIA®, Siemens NX, Parasolid, Solid Edge, SolidWorks, CoventorWare®, Mecadtron®, NASTRAN, STL or OBJ files
- Import of 2D CAD data from DXF™, GDSII and Gerber RS274X, RS274D files
- Import of EDA data from design flows including Cadence Allegro® / APD® / SiP®, Mentor Graphics Expedition®, Mentor Graphics PADS®, Mentor Graphics HyperLynx®, Zuken CR-5000® / CR-8000® and ODB++® (e.g. Mentor Graphics Boardstation®, CADSTAR®, Visula®)
- Import of PCB designs originating from CST PCB Studio®
- Import of 2D and 3D sub models
- Import of Agilent ADS® layouts
- Import of Sonnet® EM models
- Import of a visible human model dataset or other voxel datasets
- Export of CAD data to ACIS SAT, ACIS SAB, IGES, STEP, NASTRAN, STL, DXF™, GDSII, Gerber or POV files
- Parameterization for imported CAD files
- Material database
- Structure templates for simplified problem setup

Particle Tracking Simulator

- Arbitrary shaped particle source surfaces
- Circular particle sources with spatially inhomogeneous current distribution
- Particle interfaces for coupling of tracking/tracking or tracking/PIC simulations
- ASCII emission data imports based on particle interfaces

- Static-, eigenmode- and multiple external field distributions as source fields
- Support for hexahedral as well as linear and curved tetrahedral meshes
- Import of tetrahedral and hexahedral source fields into simulations

- Space charge limited, plasma-sheath, thermionic, fixed and field-induced emission model
- Oblique emission
- Secondary electron emission induced by ions or electrons as material property
- Optically stimulated electron emission

- Definable material transparency of sheets for particles
- Consideration of space charge via gun iteration
- Consideration of self-magnetic fields in gun iteration

- Analysis of extracted particle current and space charge
- Monitoring of beam cross-section, phase-space diagram and other statistical data of the beam
- Emittance calculation
- Thermal coupling (export of thermal loss distribution from crashed particles)

- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for remote computations
- Coupled simulations with the Thermal Solver from CST Studio Suite
- Support of Linux batch mode

Note: some solvers features may be available for hexahedral or tetrahedral meshes only.

Electrostatic Particle-in-Cell Simulator

- Arbitrary shaped particle source surfaces
- Circular particle sources with spatially inhomogeneous current distribution
- Volumetric particle source featuring Maxwellian distribution
- Particle interfaces for coupling of tracking/tracking or tracking/PIC simulations
- ASCII emission data imports based on particle interfaces

- Static-, eigenmode- and multiple external field distributions as source fields
- Support for hexahedral as well as linear and curved tetrahedral meshes
- Import of tetrahedral and hexahedral source fields into simulations

- Gaussian-, DC-, field induced- and explosive emission model
- Oblique emission
- Secondary electron emission induced by ions or electrons as material property
- Volume ionization based on Monte-Carlo collision model
- Definable material transparency of sheets for particles
- Analysis of extracted particle current and space charge
- User defined excitation signals and signal database
- Monitoring of beam cross-section, phase-space diagram and other statistical data of the beam
- Particle Monitors on Solids or Boundaries including Energy Histogram
- Phase space monitoring
- Thermal coupling (export of thermal loss distribution from crashed particles)

- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for remote computations
- Coupled simulations with the Thermal Solver from CST Studio Suite
- Support of Linux batch mode

Note: some solvers features may be available for hexahedral or tetrahedral meshes only.

Particle-in-Cell Simulator

- Arbitrary shaped particle source surfaces
- Circular particle sources with spatially inhomogeneous current distribution
- Circular particle source in open boundaries
- Volumetric particle source featuring Maxwellian distribution
- Gaussian-, DC-, field induced- and explosive emission model
- Oblique emission
- Particle interfaces for coupling of tracking and PIC simulations
- ASCII emission data imports based on particle interfaces
- Static-, eigenmode- and multiple external field distributions as additional source fields
- Import of tetrahedral source fields
- Automatic detection of multipaction breakdown

- Support for Single- / Multi-GPU acceleration
- Single node parallelization
- Support of Linux batch mode

- Online visualization of intermediate results during simulation
- Calculation of field distributions as a function of time or at multiple selected frequencies from one simulation run
- Time domain monitoring of particle position and momentum
- Particle Monitors on Solids or Boundaries including Energy Histogram
- Time domain monitoring of output power
- Time domain monitoring of particle current density
- Phase space monitoring
- Emittance calculation
- Secondary electron emission induced by ions or electrons as material property
- Volume ionization based on Monte-Carlo collision model
- Definable material transparency of sheets for particles
- Isotropic and anisotropic material properties
- Frequency dependent material properties with arbitrary order for permittivity and permeability as well as a material parameter fitting functionality
- Field-dependent microwave plasma and gyrotropic materials (magnetized ferrites)
- Non-linear material models (Kerr, Raman)
- Surface impedance models (tabulated surface impedance, Ohmic sheet, lossy metal, corrugated wall, material coating)
- Frequency dependent multilayered thin panel materials (isotropic and symmetric)
- Time dependent conductive materials

- Port mode calculation by a 2D eigenmode solver in the frequency domain
- Efficient calculation of higher order port modes by specifying target frequency
- Automatic waveguide port mesh adaptation
- Multipin ports for TEM mode ports with multiple conductors
- User defined excitation signals and signal database

- Charge absorbing open boundaries for CPU solver
- High performance radiating/absorbing boundary conditions
- Conducting wall boundary conditions

- Calculation of various electromagnetic quantities such as electric fields, magnetic fields, surface currents, power flows, current densities, power loss densities, electric energy densities, magnetic energy densities, voltages or currents in time and frequency domain
- Calculation of time averaged power loss volume monitors
- Calculation of time averaged surface losses

- Discrete edge and face elements (lumped resistors) as ports
- Ideal voltage and current sources
- Discrete edge and face R, L, C, and (nonlinear) diode elements at any location in the structure



- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for remote computations
- Support for Transient Co-Simulation with CST Design Studio™
- Coupled simulations with the Thermal Solver from CST Studio Suite

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Wakefield Simulator

- Particle beam excitation for ultra-relativistic and non-relativistic beams
- Transmission line injection scheme (improved dispersion characteristics)
- Arbitrary particle beam shapes for ultra-relativistic beams
- Automatic wake-potential calculation
- Automatic wake-impedance, loss and kick factor calculation
- Wakefield postprocessor allows to recompute wake impedances
- Mesh settings for particle beams
- Direct and two indirect wake-integration methods available

- MPI Cluster parallelization via domain decomposition
- Support of Linux batch mode

- Efficient calculation for loss-free and lossy structures
- Calculation of field distributions as a function of time or at multiple selected frequencies from one simulation run
- Adaptive mesh refinement in 3D
- Isotropic and anisotropic material properties
- Frequency dependent material properties
- Gyrotropic materials (magnetized ferrites)
- Surface impedance model for good conductors

- Port mode calculation by a 2D eigenmode solver in the frequency domain
- Automatic waveguide port mesh adaptation
- Multipin ports for TEM mode ports with multiple conductors

- High performance absorbing boundary conditions also for charged particle beams
- Conducting wall boundary conditions

- Calculation of various electromagnetic quantities such as electric fields, magnetic fields, surface currents, power flows, current densities, power loss densities, electric energy densities, magnetic energy densities, voltages or currents in time and frequency domain
- Calculation of time averaged power loss volume monitors
- Calculation of time averaged surface losses
- Discrete edge and face elements (lumped resistors) as ports
- Ideal voltage and current sources
- Discrete edge and face R, L, C, and (nonlinear) diode elements at any location in the structure

- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for optimizations, parameter sweeps and multiple port/mode excitations
- Support for Transient Co-Simulation with CST Design Studio™
- Coupled simulations with the Thermal Solver from CST Studio Suite

Eigenmode Simulator

- Calculation of modal field distributions in closed loss-free or lossy structures
- Support of hexahedral meshes as well as linear and curved tetrahedral meshes
- Isotropic and anisotropic materials
- Multithread parallelization
- Adaptive mesh refinement in 3D using eigenmode frequencies as stop criteria, with True Geometry Adaptation
- Periodic boundary conditions including phase shift

- Calculation of losses and internal / external Q-factors for each mode (directly or using perturbation method)
- Discrete L,C elements at any location in the structure
- Target frequency can be set (calculation within the frequency interval)
- Calculation of all eigenmodes in a given frequency interval
- Sensitivity analysis with respect to materials and geometric deformations defined by face constraints (with tetrahedral mesh)
- Automatic Lorentz force calculation

- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for optimizations and parameter sweeps
- Coupled simulations with the Thermal Solver from CST Studio Suite

Electrostatics Simulator

- Isotropic and (coordinate-dependent) anisotropic material properties
- Sources: potentials, charges on conductors (floating potentials), uniform volume- and surface-charge densities
- Force calculation
- Capacitance calculation
- Electric / magnetic / tangential / normal / open / fixed-potential boundary conditions
- Perfect conducting sheets and wires
- Discrete edge capacitive elements at any location in the structure
- Adaptive mesh refinement in 3D
- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for optimizations, parameter sweeps and remote calculations
- Coupled simulations with the Mechanical Solver from CST Studio Suite

Magnetostatics Simulator

- Isotropic and (coordinate-dependent) anisotropic material properties
- Nonlinear material properties
- Laminated material properties
- Sources: coils, permanent magnets, current paths, external fields, stationary current fields
- Discrete edge inductances at any location in the structure
- Force calculation
- Inductance calculation
- Flux linkages
- Electric / magnetic / tangential / normal / open boundary conditions
- Adaptive mesh refinement in 3D
- Automatic parameter studies using built-in parameter sweep tool
- Automatic structure optimization for arbitrary goals using built-in optimizer
- Network distributed computing for optimizations, parameter sweeps and remote calculations
- Coupled simulations with the Mechanical Solver from CST Studio Suite

Visualization and Secondary Result Calculation

- Multiple 1D result view support
- Import and visualization of external xy-data
- Copy / Paste of xy-datasets
- Fast access to parametric data by interactive tuning sliders
- Automatic parametric 1D result storage

- Displays port modes (with propagation constant, impedance, etc.)
- Various field visualization options in 2D and 3D for electric fields, magnetic fields, power flows, surface currents, etc.
- Animation of field distributions



- Particle and secondary electrons vs. time 1D plots (PIC)
- Current/Power 1D plot of emitted and absorbed particles (PIC)
- Wave-Particle Power Transfer (PIC)
- Animation of 2D and 3D particle positions / momenta (PIC)
- Visualization of 3D particle trajectories (Tracking)
- Combined Visualization of 2D/3D fields and particle positions (PIC)

- Display of source definitions in 3D
- Display of nonlinear material curves in xy-plots
- Display of material distributions for materials with nonlinear permeability
- Animation of field distributions

- Display and integration of 2D and 3D fields along arbitrary curves
- Integration of 3D fields across arbitrary faces
- Hierarchical result templates for automated extraction and visualization of arbitrary results from various simulation runs. These data can also be used for the definition of optimization goals.

Result Export

- Export of result data such as fields, curves, etc. as ASCII files
- Export of particle data as ASCII files
- Export screen shots of result field plots

Automation

- Powerful VBA (Visual Basic for Applications) compatible macro language including editor and macro debugger
- OLE automation for seamless integration into the Windows environment (Microsoft Office®, MATLAB®, AutoCAD®, MathCAD®, Windows Scripting Host, etc.)